Sea	rch	rch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/708,489	CHANG ET AL.
Examiner	Art Unit
Y. J. Han	2838

SEARCHED			
Class		 	
Class	Subclass	Date	Examiner
323	312		
	313		
	314		
	274		
	275		
	276		
	277		
	280		
	281		
327	530		
	534		
	535		
	540		
Search	updated	12/21/2006	jh

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
		<u>.</u>		

1	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
		•	
	!		